

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10800105	KUROIWA, TAKESHI
	Examiner TRAN, MY-CHAU T	Art Unit 2629

SEARCHED

Class	Subclass	Date	Examiner
345	156, 169	1/9/07	MCT

SEARCH NOTES

Search Notes	Date	Examiner
PALM Inventor; WEST - see printout	1/9/07	MCT

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner